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Kind regards,

Team Nexperia

74CBTLVD3384

10-bit level-shifting bus switch with 5-bit output enables

Rev. 2 — 16 December 2011

Product data sheet

1. General description

The 74CBTLVD3384 is <u>a dual 5-pole</u>, single-throw bus switch. The device features two output enable inputs (nOE) that <u>each</u> control five switch channels. The switches are disabled when the associated nOE input is HIGH. Schmitt-trigger action at control inputs makes the circuit tolerant of slower input rise and fall times. This device is fully specified for partial power-down applications using I_{OFF}. The I_{OFF} circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

2. Features and benefits

- Supply voltage range from 3.0 V to 3.6 V
- High noise immunity
- Complies with JEDEC standard:
 - ◆ JESD8-B/JESD36 (3.0 V to 3.6 V)
- ESD protection:
 - ◆ HBM JESD22-A114F exceeds 2000 V
 - CDM AEC-Q100-011 revision B exceeds 1000 V
- \blacksquare 5 Ω switch connection between two ports
- -3 dB bandwidth at 600 MHz
- Rail to rail switching on data I/O ports
- CMOS low power consumption
- Latch-up performance exceeds 250 mA per JESD78B Class I level A
- I_{OFF} circuitry provides partial Power-down mode operation
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



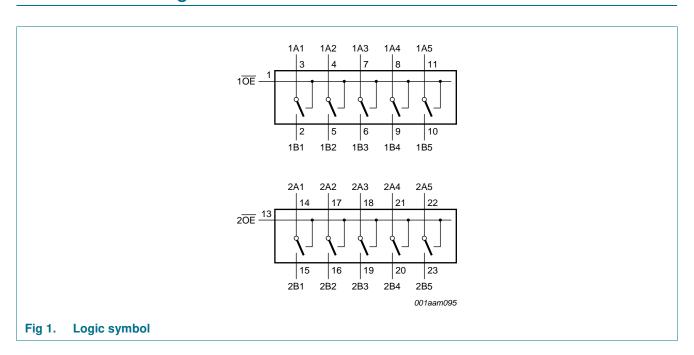
3. Ordering information

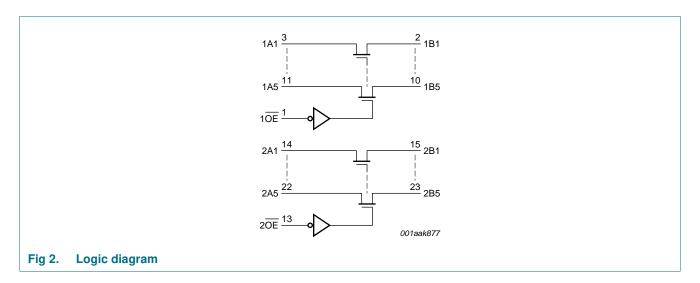
Table 1. Ordering information

Type number	Package							
	Temperature range	Name	Description	Version				
74CBTLVD3384DK	-40 °C to +125 °C	SSOP24[1]	plastic shrink small outline package; 24 leads; body width 3.9 mm; lead pitch 0.635 mm	SOT556-1				
74CBTLVD3384PW	–40 °C to +125 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1				
74CBTLVD3384BQ	–40 °C to +125 °C	DHVQFN24	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 24 terminals; body $3.5\times5.5\times0.85$ mm	SOT815-1				

^[1] Also known as QSOP24 package

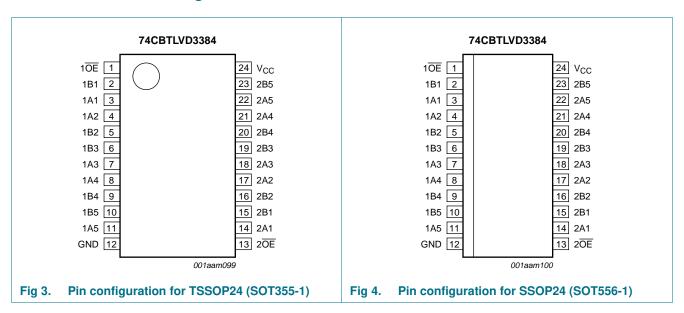
4. Functional diagram

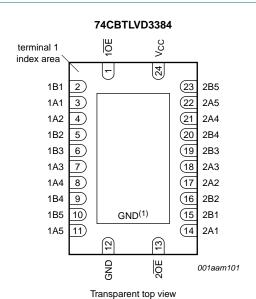




5. Pinning information

5.1 Pinning





(1) This is not a supply pin, the substrate is attached to this pad using conductive die attach material. There is no electrical or mechanical requirement to solder this pad however if it is soldered the solder land should remain floating or be connected to GND.

Fig 5. Pin configuration for DHVQFN24 (SOT815-1)

5.2 Pin description

Table 2. Pin description

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Symbol	Pin	Description				
1 OE , 2 OE	1, 13	output enable input (active LOW)				
1A1 to 1A5	3, 4, 7, 8, 11	data input/output (A port)				
2A1 to 2A5	14, 17, 18, 21, 22	data input/output (A port)				
1B1 to 1B5	2, 5, 6, 9, 10	data input/output (B port)				
2B1 to 2B5	15, 16, 19, 20, 23	data input/output (B port)				
GND	12	ground (0 V)				
V _{CC}	24	positive supply voltage				

6. Functional description

Table 3. Function selection[1]

		Input/output			
10E	2OE	1An, 1Bn	2An, 2Bn		
L	L	1An = 1Bn	2An = 2Bn		
L	Н	1An = 1Bn	Z		
Н	L	Z	2An = 2Bn		
Н	Н	Z	Z		

[1] H = HIGH voltage level; L = LOW voltage level; Z = high-impedance OFF-state.

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7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+4.6	V
V _I	input voltage		<u>[1]</u> –0.5	+4.6	V
V _{SW}	switch voltage	enable and disable mode	<u>[1]</u> –0.5	$V_{CC} + 0.5$	V
I _{IK}	input clamping current	$V_{I/O} < -0.5 \text{ V}$	–50	-	mA
I _{SK}	switch clamping current	$V_{I} < -0.5 \text{ V}$	–50	-	mA
I _{SW}	switch current	$V_{SW} = 0 V to V_{CC}$	-	±128	mA
I _{CC}	supply current		-	+100	mA
I _{GND}	ground current		-100	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$	[2] _	500	mW

^[1] The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

8. Recommended operating conditions

Table 5. Recommended operating conditions

	<u> </u>				
Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		3.0	3.6	V
VI	input voltage		0	3.6	V
V_{SW}	switch voltage	enable and disable mode	0	V_{CC}	V
T _{amb}	ambient temperature		-40	+125	°C
$\Delta t/\Delta V$	input transition rise and fall rate	V _{CC} = 3.0 V to 3.6 V	<u>[1]</u> 0	200	ns/V

^[1] Applies to control signal levels.

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$			T _{amb} = -40 °0	Unit	
			Min	Typ[1]	Max	Min	Max	
V_{IH}	HIGH-level input voltage	$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.0	-	-	2.0	-	V
V_{IL}	LOW-level input voltage	$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	-	0.9	-	0.9	V
I	input leakage current	pin $n\overline{OE}$; $V_1 = GND$ to V_{CC} ; $V_{CC} = 3.6 \text{ V}$	-	-	±1	-	±20	μА
V _{pass}	pass voltage	$V_1 = V_{CC}$; see <u>Figure 9</u> to <u>Figure 12</u>	-	-	-	-	-	V

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^[2] For SSOP24 and TSSOP24 packages: P_{tot} derates linearly with 5.5 mW/K above 60 °C. For DHVQFN24 package: P_{tot} derates linearly at 4.5 mW/K above 60 °C.

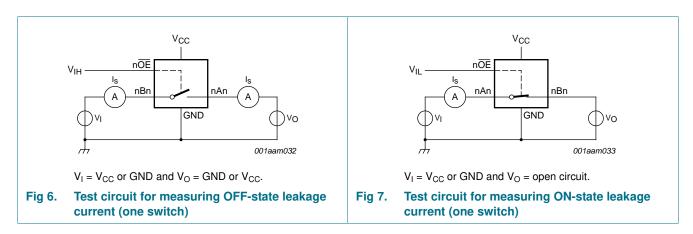
Table 6. Static characteristics ...continued

At recommended operating conditions voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T _{amb} =	–40 °C to	+85 °C	$T_{amb} = -40$ °C	C to +125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
I _{S(OFF)}	OFF-state leakage current	$V_{CC} = 3.6 \text{ V}$; see Figure 6	-	-	±1	-	±20	μΑ
I _{S(ON)}	ON-state leakage current	$V_{CC} = 3.6 \text{ V}$; see Figure 7	-	-	±1	-	±20	μΑ
I _{OFF}	power-off leakage current	V_I or $V_O = 0$ V to 3.6 V; $V_{CC} = 0$ V	-	-	±10	-	±50	μΑ
I _{CC}	supply current	$V_I = V_{CC}$; $I_O = 0$ A; $V_{CC} = 3.6$ V; $V_{SW} = GND$ or V_{CC}	-	-	20	-	50	μΑ
		$V_I = GND$; $I_O = 0$ A; $V_{CC} = 3.6$ V; $V_{SW} = GND$ or V_{CC}	-	-	100	-	150	μΑ
ΔI_{CC}	additional supply current	pin n \overline{OE} ; V _I = V _{CC} - 0.6 V; V _{SW} = GND or V _{CC} ; V _{CC} = 3.6 V	-	-	300	-	2000	μΑ
C _I	input capacitance	pin \overline{OE} ; $V_{CC} = 3.3 \text{ V}$; $V_I = 0 \text{ V}$ to 3.3 V	-	0.9	-	-	-	pF
$C_{S(OFF)}$	OFF-state capacitance	$V_{CC} = 3.3 \text{ V}; V_I = 0 \text{ V to } 3.3 \text{ V}$	-	2.5	-	-	-	pF
C _{S(ON)}	ON-state capacitance	$V_{CC} = 3.3 \text{ V}; V_I = 0 \text{ V to } 3.3 \text{ V}$	-	9.0	-	-	-	pF

^[1] All typical values are measured at $T_{amb} = 25$ °C.

9.1 Test circuits



^[2] One input at 3 V, other inputs at V_{CC} or GND.

9.2 Typical pass voltage graphs

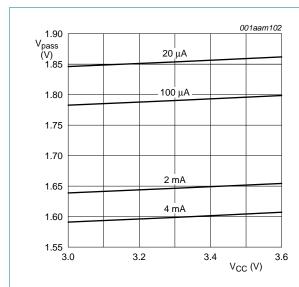


Fig 8. Pass voltage versus supply voltage; $T_{amb} = 125$ °C (typical)

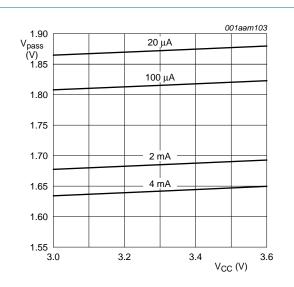


Fig 9. Pass voltage versus supply voltage; T_{amb} = 85 °C (typical)

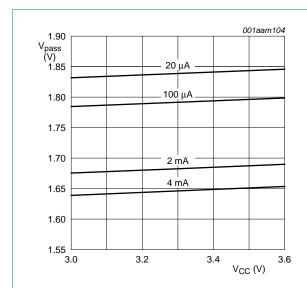


Fig 10. Pass voltage versus supply voltage; T_{amb} = 25 °C (typical)

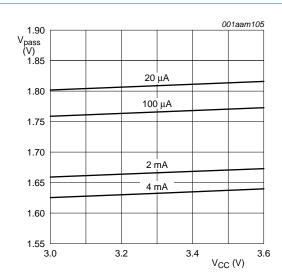
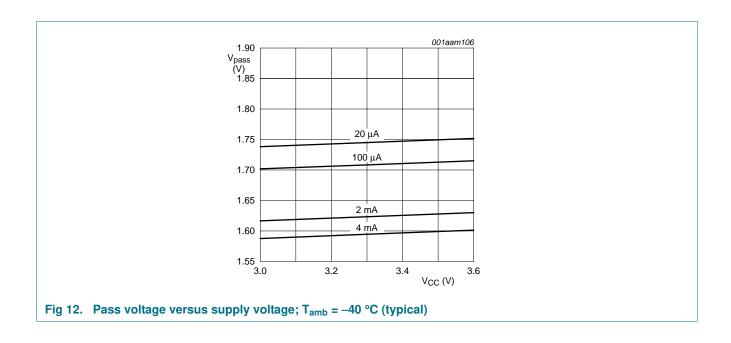


Fig 11. Pass voltage versus supply voltage; $T_{amb} = 0$ °C (typical)



9.3 ON resistance

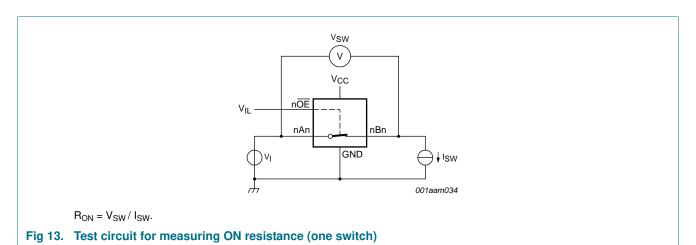
Table 7. Resistance R_{ON}

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 13.

Symbol	Parameter	Conditions	T _{amb} =	–40 °C to	+85 °C	T _{amb} = -40 °	Unit	
			Min	Typ[1]	Max	Min	Max	
R _{ON}	ON resistance	$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$						
		$I_{SW} = 64 \text{ mA}; V_I = 0 \text{ V}$	-	3.7	7.0	-	10.0	Ω
		$I_{SW} = 24 \text{ mA}; V_I = 0 \text{ V}$	-	3.7	7.0	-	10.0	Ω
		$I_{SW} = 15 \text{ mA}; V_I = 1.2 \text{ V}$	-	4.7	10.0	-	12.0	Ω

^[1] Typical values are measured at T_{amb} = 25 °C and nominal V_{CC} .

9.4 ON resistance test circuit



^[2] Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

10. Dynamic characteristics

Table 8. Dynamic characteristics

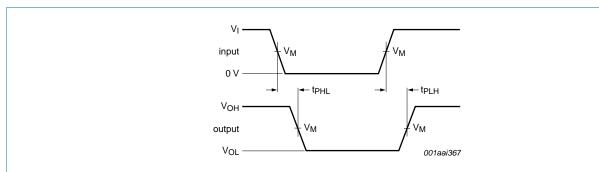
GND = 0 V; for test circuit see Figure 16

Symbol	Parameter	Conditions		$T_{amb} = -40$ °C to +85 °C			T _{amb} = -40 °	Unit	
					Typ[1]	Max	Min	Max	
t _{pd} propagation delay		nAn to nBn or nBn to nAn; see Figure 14	2][3]						
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	-	0.11	-	0.22	ns
t _{en}	enable time	nOE to nAn or nBn; see Figure 15	[4]						
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		1.5	2.8	5.0	1.5	6.0	ns
t _{dis} disable time		nOE to nAn or nBn; see <u>Figure 15</u>	[5]						
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		8.0	3.2	7.0	8.0	8.0	ns

^[1] All typical values are measured at T_{amb} = 25 °C and at nominal V_{CC} .

- [3] t_{pd} is the same as t_{PLH} and t_{PHL} .
- [4] t_{en} is the same as t_{PZH} and t_{PZL} .
- [5] t_{dis} is the same as t_{PHZ} and t_{PLZ}.

11. Waveforms



Measurement points are given in Table 9.

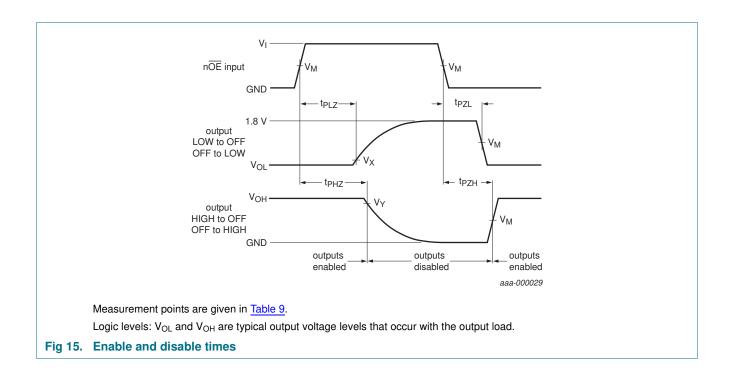
Logic levels: V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

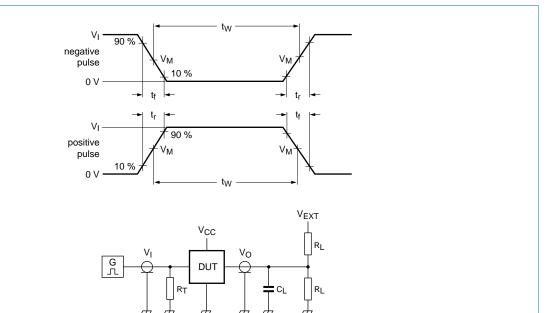
Fig 14. The data input (nAn, nBn) to output (nBn, nAn) propagation delay times

Table 9. Measurement points

Supply voltage	Input			Output			
V _{CC}	V _M V _I t		$t_r = t_f$	V _M	V _X	V _Y	
3.0 V to 3.6 V	0.5V _{CC}	V _{CC}	≤ 2.0 ns	0.9 V	V _{OL} + 0.15 V	$V_{OH} - 0.15 \ V$	

^[2] The propagation delay is the calculated RC time constant of the on-state resistance of the switch and the load capacitance, when driven by an ideal voltage source (zero output impedance).





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Test data is given in Table 10.

Definitions for test circuit:

 R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance should be equal to the output impedance Z_0 of the pulse generator.

 V_{EXT} = External voltage for measuring switching times.

Fig 16. Test circuit for measuring switching times

Table 10. Test data

Supply voltage	Load	V _{EXT}			
V _{CC}	C _L	R _L	t _{PLH} , t _{PHL}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}
3.0 V to 3.6 V	30 pF	1 kΩ	open	GND	3.6 V

11.1 Additional dynamic characteristics

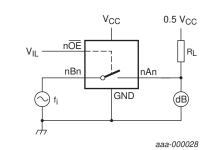
Table 11. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); V_l = GND or V_{CC} (unless otherwise specified); $t_r = t_f \le 2.5$ ns.

Symbol	Parameter	Conditions		T _{amb} = 25 °C			Unit
				Min	Typ[1]	Max	
f _(-3dB)	-3 dB frequency response	V_{CC} = 3.3 V; R_L = 50 Ω ; see Figure 17	[2]	-	575	-	MHz

- [1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 3.3 V.
- [2] f_i is biased at $0.5V_{CC}$.

11.2 Test circuits

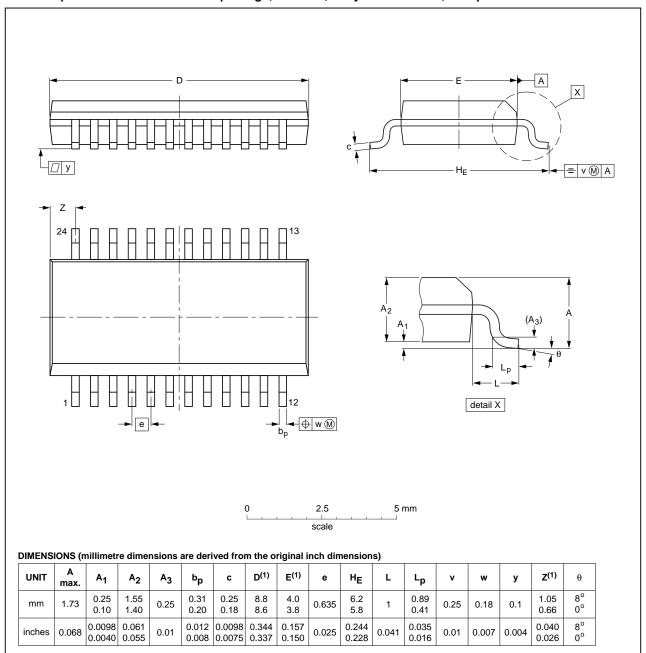


nOE connected to GND; Adjust f_i voltage to obtain 0 dBm level at output. Increase f_i frequency until dB meter reads –3 dB.

Fig 17. Test circuit for measuring the frequency response when channel is in ON-state

12. Package outline

SSOP24: plastic shrink small outline package; 24 leads; body width 3.9 mm; lead pitch 0.635 mm SOT556-1



Note

1. Plastic or metal protrusions of 0.2 mm (0.008 inch) maximum per side are not included.

OUTLINE VERSION		REFER	EUROPEAN	ISSUE DATE		
	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT556-1		MO-137				99-12-27 03-02-18

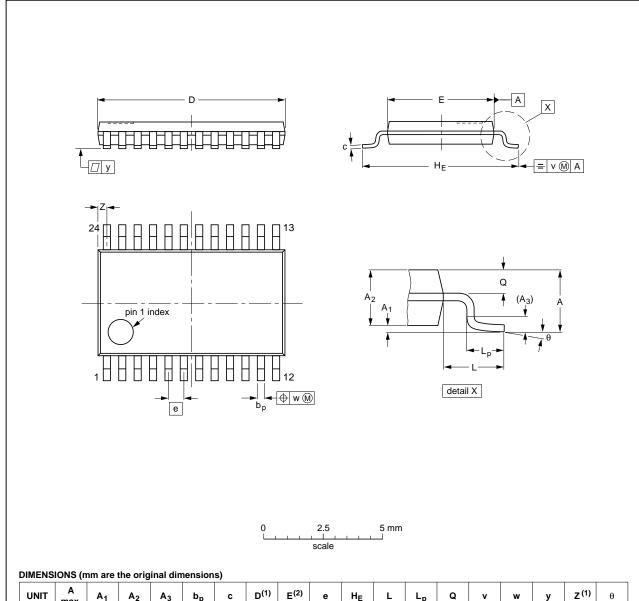
Fig 18. Package outline SOT556-1 (SSOP24)

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TSSOP24: plastic thin shrink small outline package; 24 leads; body width 4.4 mm

SOT355-1



						~,												
UNIT	. A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	7.9 7.7	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT355-1		MO-153				99-12-27 03-02-19
	I .					

Fig 19. Package outline SOT355-1 (TSSOP24)

74CBTLVD3384

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DHVQFN24: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 24 terminals; body $3.5 \times 5.5 \times 0.85$ mm

SOT815-1

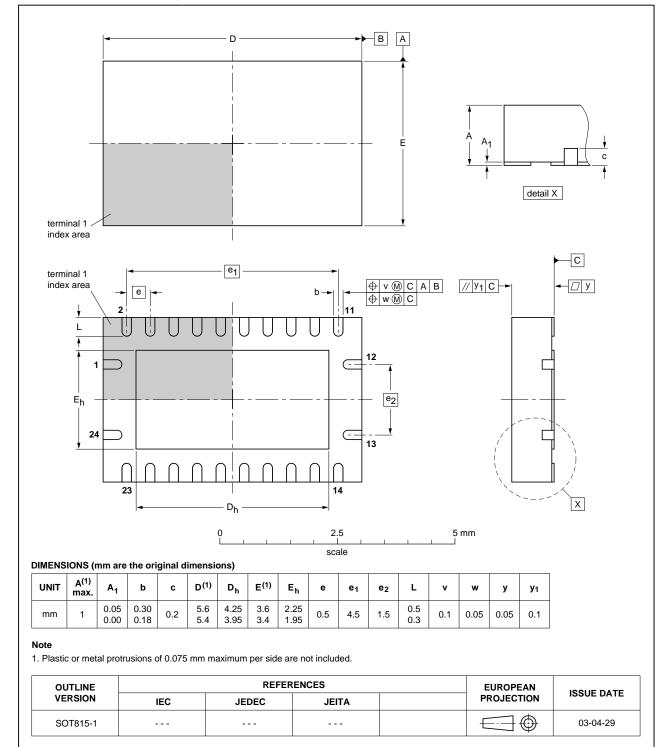


Fig 20. Package outline SOT815-1 (DHVQFN24)

74CBTLVD3384

13. Abbreviations

Table 12. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model

14. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74CBTLVD3384 v.2	20111216	Product data sheet	-	74CBTLVD3384 v.1
Modifications:	 Legal pages 	updated.		
74CBTLVD3384 v.1	20110719	Product data sheet	-	-

15. Legal information

15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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